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88D 14828 D T-39-13

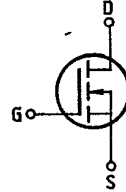
BUZ 88

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**Main ratings**

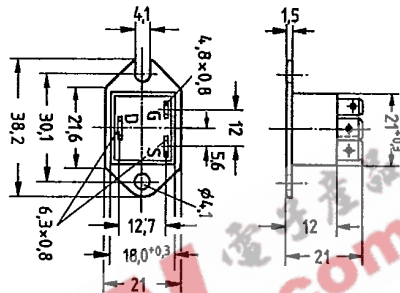
Drain-source voltage  $V_{DS} = 800$  V  
 Continuous drain current  $I_D = 4,3$  A  
 Drain-source on-resistance  $R_{DS(on)} = 2,0 \Omega$

N-Channel



**Description** SiPMOS, N-channel, enhancement mode  
**Case** Plastic package TO 238 AA with insulated metal base plate in accordance with JEDEC, compatible with TO 3; AMP plug-in connections.  
 Approx. weight 21 g

Type	Ordering code
BUZ 88	C67078-A1609-A2



Dimensions in mm

**Maximum ratings**

Description	Symbols	RATINGS	Units	Conditions
Drain-source voltage	$V_{DS}$	800	V	
Drain-gate voltage	$V_{DGR}$	800	V	$R_{DS} = 20 \text{ k}\Omega$
Continuous drain current	$I_D$	4,3	A	$T_C = 25 \text{ }^\circ\text{C}$
Pulsed drain current	$I_{D(puls)}$	17	A	$T_C = 25 \text{ }^\circ\text{C}$
Gate-source voltage	$V_{GS}$	$\pm 20$	V	
Max. power dissipation	$P_D$	83,3	W	$T_C = 25 \text{ }^\circ\text{C}$
Operating and storage temperature range	$T_j$ $T_{stg}$	-40 ... +150	$^\circ\text{C}$	
Isolation test voltage	$V_{is}$	3500	Vdc <sup>1)</sup>	$t = 1 \text{ min}$
DIN humidity category	F		-	DIN 40040
IEC climatic category	40/150/56			DIN IEC 68-1

**Thermal resistance**

Chip - case |  $R_{thJC}$  |  $\leq 1,5$  | K/W |

<sup>1)</sup> Isolation test voltage between drain and base plate referred to standard climate 23/50 in accordance with DIN 50014.

**Electrical characteristics**(at  $T_j = 25^\circ\text{C}$  unless otherwise specified)

Description	Symbol	Characteristics			Unit	Conditions
		min.	typ.	max.		

**Static ratings**

Drain-source breakdown voltage	$V_{(BR)DSS}$	800	—	—	V	$V_{GS} = 0V$ $I_D = 0,25mA$
Gate threshold voltage	$V_{GS(th)}$	2,1	3,0	4,0		$V_{DS} = V_{GS}$ $I_D = 1mA$
Zero gate voltage drain current	$I_{DSS}$	—	20 100	250 1000	$\mu A$	$T_j = 25^\circ C$ $T_j = 125^\circ C$ $V_{DS} = 800V$ $V_{GS} = 0V$
Gate-source leakage current	$I_{GSS}$	—	10	100	nA	$V_{GS} = 20V$ $V_{DS} = 0V$
Drain-source on-resistance	$R_{DS(on)}$	—	1,7	2,0	$\Omega$	$V_{GS} = 10V$ $I_D = 3A$

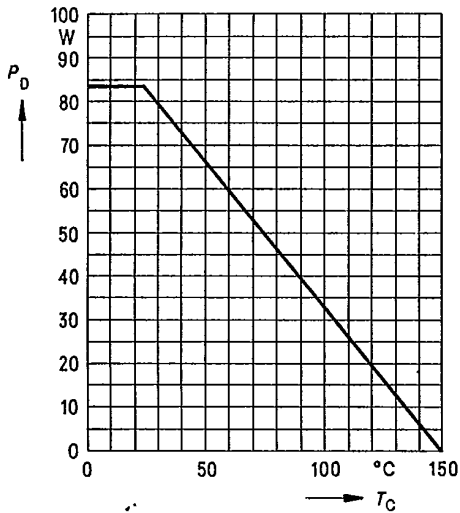
**Dynamic ratings**

Forward transconductance	$g_{fs}$	1,8	3,0	—	S	$V_{DS} = 25V$ $I_D = 3A$
Input capacitance	$C_{iss}$	—	3,9	5,0	nF	$V_{GS} = 0V$ $V_{DS} = 25V$
Output capacitance	$C_{oss}$	—	200	350	pF	$f = 1MHz$
Reverse transfer capacitance	$C_{rss}$	—	80	140		
Turn-on time $t_{on}$ ( $t_{on} = t_{d(on)} + t_r$ )	$t_{d(on)}$ $t_r$	—	60 90	90 140	ns	$V_{CC} = 30V$ $I_D = 2,5A$ $V_{GS} = 10V$ $R_{GS} = 50\Omega$
Turn-off time $t_{off}$ ( $t_{off} = t_{d(off)} + t_f$ )	$t_{d(off)}$ $t_f$	—	330 110	430 140		

**Reverse diode**

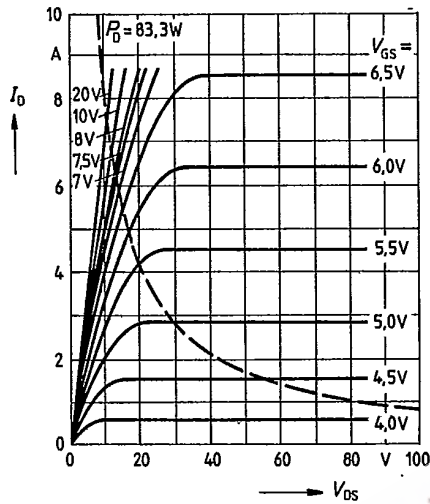
Continuous reverse drain current	$I_{DR}$	—	—	4,3	A	$T_C = 25^\circ C$
Pulsed reverse drain current	$I_{DRM}$	—	—	17		
Diode forward on-voltage	$V_{SD}$	—	1,1	1,4	V	$I_F = 2 \times I_{DR}$ $V_{GS} = 0V, T_j = 25^\circ C$
Reverse recovery time	$t_{rr}$	—	1800	—	ns	$T_j = 25^\circ C$
Reverse recovery charge	$Q_{rr}$	—	25	—	$\mu C$	$I_F = I_{DR}$ $dI_F/dt = 100A/\mu s$ $V_R = 100V$

Power dissipation  $P_D = f(T_C)$

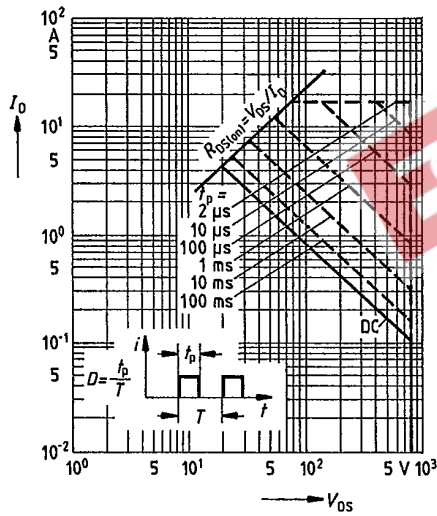


Typical output characteristics  $I_D = f(V_{DS})$

parameter: 80  $\mu$ s pulse test,  
 $T_j = 25^\circ\text{C}$

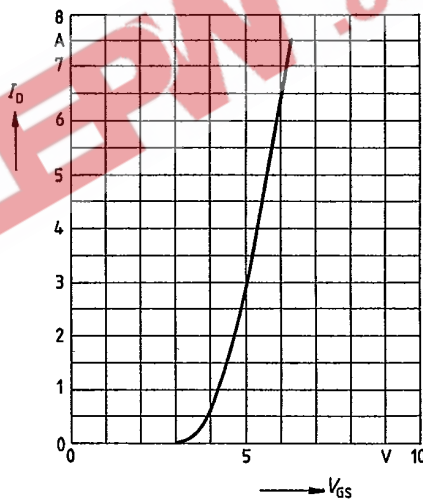


Safe operating area  $I_D = f(V_{DS})$   
parameter:  $D = 0.01$ ,  $T_C = 25^\circ\text{C}$



Typical transfer characteristic  $I_D = f(V_{GS})$

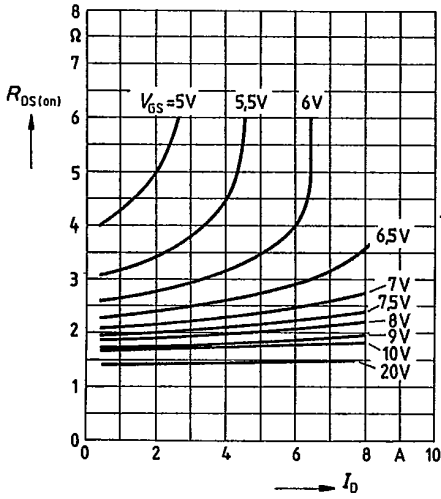
parameter: 80  $\mu$ s pulse test,  
 $V_{DS} = 25\text{V}$ ,  $T_j = 25^\circ\text{C}$



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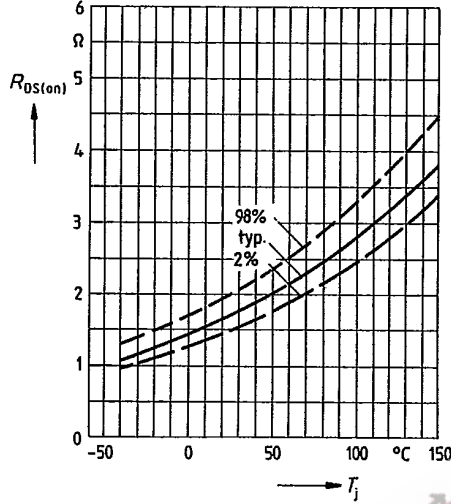
Typical drain-source on-state resistance

$R_{DS(on)} = f(I_D)$   
parameter:  $V_{GS} = T_j = 25^\circ\text{C}$



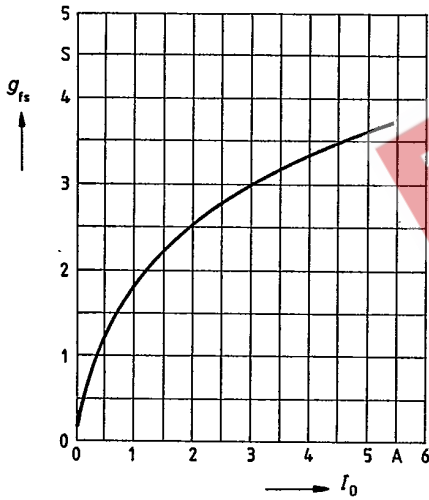
Drain-source on-state resistance

$R_{DS(on)} = f(T_j)$   
parameter:  $I_D = 3\text{A}, V_{GS} = 10\text{V}$   
(spread)



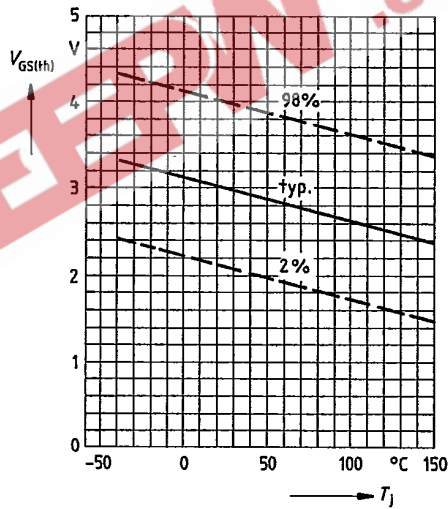
Typical transconductance  $g_{fs} = f(I_D)$

parameter: 80  $\mu\text{s}$  pulse test,  
 $V_{DS} = 25\text{V}, T_j = 25^\circ\text{C}$



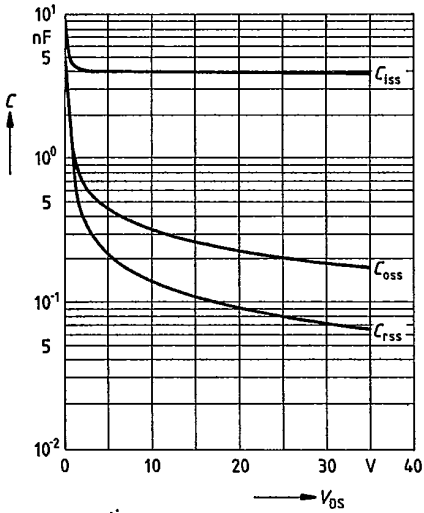
Gate threshold voltage  $V_{GS(th)} = f(T_j)$

parameter:  $V_{DS} = V_{GS}, I_D = 1\text{mA}$   
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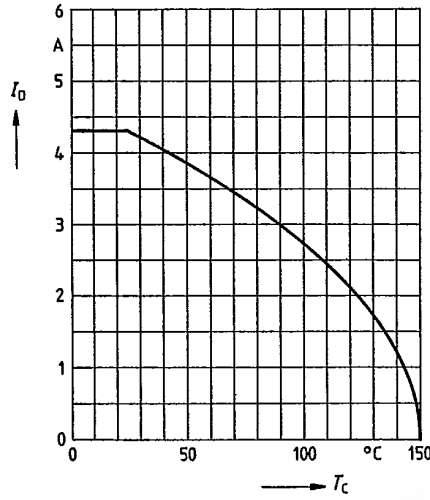


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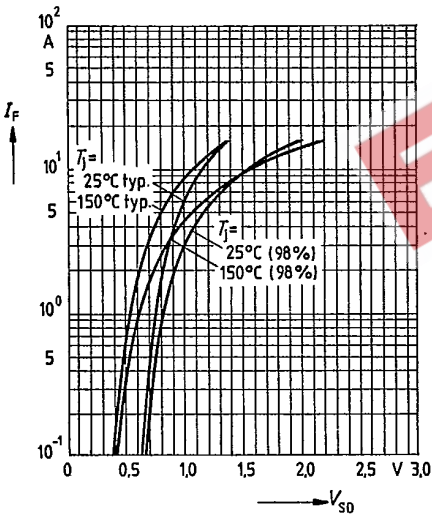
Typical capacitances  $C = f(V_{DS})$   
parameter:  $V_{GS} = 0, f = 1\text{MHz}$



Continuous drain current  $I_D = f(T_C)$   
parameter:  $V_{GS} \geq 10\text{V}$



Forward characteristic of reverse diode  
 $I_F = f(V_{SD})$   
parameter:  $T_j, t_p = 80 \mu\text{s}$   
(spread)



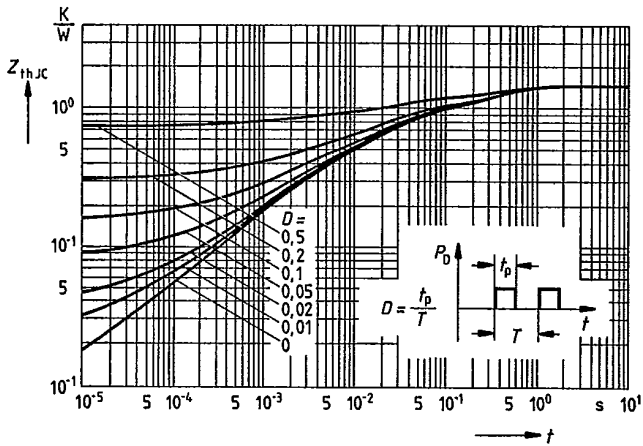
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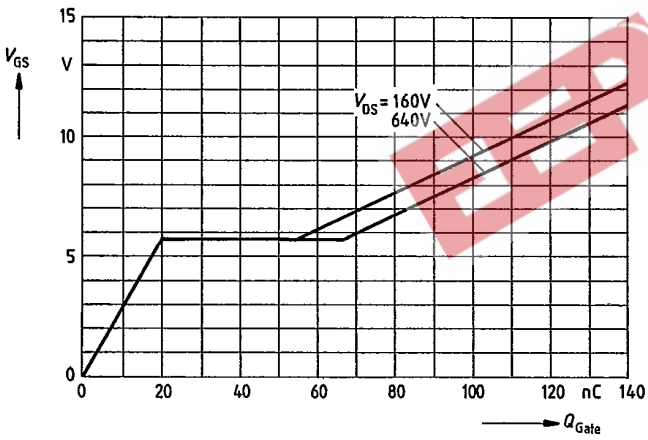
C-13

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Transient thermal impedance  $Z_{thJC} = f(t)$   
 parameter:  $D = t_p/T$



Typical gate-charge  $V_{GS} = f(Q_{Gate})$   
 parameter:  $I_{D\ pulse} = 9A$



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